# International Rectifier

#### **AUTOMOTIVE GRADE**

# AUIRL1404Z AUIRL1404ZL

#### **Features**

- Logic Level
- Advanced Process Technology
- Ultra Low On-Resistance
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax
- · Lead-Free, RoHS Compliant

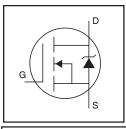
Absolute Maximum Ratings

Automotive Qualified \*

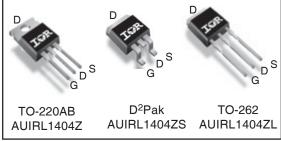
#### Description

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low onresistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.

### HEXFET® Power MOSFET



V <sub>(BR)DSS</sub>	40V
R <sub>DS(on)</sub> ty	o. <b>2.5m</b> Ω
m	ax. 3.1mΩ
I <sub>D (Silicon Limit</sub>	ted) 180A ®
I <sub>D (Package Lii</sub>	nited) 160A



G	D	S
Gate	Drain	Source

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (T<sub>A</sub>) is 25°C, unless otherwise specified.

	Parameter	Max.	Units
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited)	180®	
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V(Silicon Limited)	130	
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V(Package Limited)	160	_ A
I <sub>DM</sub>	Pulsed Drain Current ①	790	
$P_D @ T_C = 25^{\circ}C$	Power Dissipation	200	W
	Linear Derating Factor	1.3	W/°C
V <sub>GS</sub>	Gate-to-Source Voltage	± 16	V
E <sub>AS</sub>	Single Pulse Avalanche Energy (Thermally limited) ②	190	mJ
E <sub>AS</sub> (Tested )	Single Pulse Avalanche Energy Tested Value ©	490	1110
I <sub>AR</sub>	Avalanche Current ①	See Fig.12a, 12b, 15, 16	Α
E <sub>AR</sub>	Repetitive Avalanche Energy ©		mJ
$T_{J}$	Operating Junction and	-55 to + 175	
T <sub>STG</sub> Storage Temperature Range			°C
	Soldering Temperature, for 10 seconds	300 (1.6mm from case )	
	Mounting Torque, 6-32 or M3 screw	10 lbf•in (1.1N•m)	

#### Thermal Resistance

www.irf.com

	Parameter	Тур.	Max.	Units
R <sub>eJC</sub>	Junction-to-Case		0.75 ⑨	
$R_{\theta CS}$	Case-to-Sink, Flat, Greased Surface ♡	0.50		°C/W
$R_{\theta JA}$	Junction-to-Ambient ⑦		62	10/00
$R_{\theta JA}$	Junction-to-Ambient (PCB Mount) ®		40	

 $\mathsf{HEXFET}^{\tiny{\circledR}}$  is a registered trademark of International Rectifier.

<sup>\*</sup>Qualification standards can be found at http://www.irf.com/

#### Static Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	40			٧	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.034		V/°C	Reference to 25°C, I <sub>D</sub> = 1mA
			2.5	3.1		V <sub>GS</sub> = 10V, I <sub>D</sub> = 75A ③* *
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance			4.7	mΩ	V <sub>GS</sub> = 5.0V, I <sub>D</sub> = 40A ③
				5.9		$V_{GS} = 4.5V, I_D = 40A$ ③
$V_{GS(th)}$	Gate Threshold Voltage	1.4		2.7	٧	$V_{DS} = V_{GS}$ , $I_D = 250\mu A$
gfs	Forward Transconductance	120			S	$V_{DS} = 10V, I_D = 75A^*$
I <sub>DSS</sub>	Drain-to-Source Leakage Current			20	μΑ	$V_{DS} = 40V, V_{GS} = 0V$
				250		$V_{DS} = 40V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I <sub>GSS</sub>	Gate-to-Source Forward Leakage			200	nA	V <sub>GS</sub> = 16V
	Gate-to-Source Reverse Leakage			-200		$V_{GS} = -16V$

### Dynamic Electrical Characteristics @ $T_J = 25$ °C (unless otherwise specified)

_ ya		`	(			oo opoomou)
	Parameter	Min.	Тур.	Max.	Units	Conditions
$Q_g$	Total Gate Charge		75	110		I <sub>D</sub> = 75A* *
$Q_{gs}$	Gate-to-Source Charge		28		nC	$V_{DS} = 32V$
$Q_{gd}$	Gate-to-Drain ("Miller") Charge		40		1	V <sub>GS</sub> = 5.0V ③
t <sub>d(on)</sub>	Turn-On Delay Time		19			$V_{DD} = 20V$
t <sub>r</sub>	Rise Time		180		1	I <sub>D</sub> = 75A* *
t <sub>d(off)</sub>	Turn-Off Delay Time		30		ns	$R_G = 4.0\Omega$
t <sub>f</sub>	Fall Time		49		1	V <sub>GS</sub> = 5.0V ③
L <sub>D</sub>	Internal Drain Inductance		4.5			Between lead,
					nH	6mm (0.25in.)
L <sub>S</sub>	Internal Source Inductance		7.5		1	from package G
			l			and center of die contact
C <sub>iss</sub>	Input Capacitance		5080			$V_{GS} = 0V$
C <sub>oss</sub>	Output Capacitance		970			$V_{DS} = 25V$
C <sub>rss</sub>	Reverse Transfer Capacitance		570		pF	f = 1.0MHz
C <sub>oss</sub>	Output Capacitance		3310	_	Ī	$V_{GS} = 0V, V_{DS} = 1.0V, f = 1.0MHz$
C <sub>oss</sub>	Output Capacitance		870	_	Ī	$V_{GS} = 0V, V_{DS} = 32V, f = 1.0MHz$
C <sub>oss</sub> eff.	Effective Output Capacitance		1280	_	Ī	$V_{GS} = 0V$ , $V_{DS} = 0V$ to 32V $\oplus$
	•					

#### **Diode Characteristics**

	Parameter	Min.	Тур.	Max.	Units	Conditions
I <sub>S</sub>	Continuous Source Current			180		MOSFET symbol
	(Body Diode)				Α	showing the
I <sub>SM</sub>	Pulsed Source Current			720		integral reverse
	(Body Diode) ①					p-n junction diode.
$V_{SD}$	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C, I_S = 75A^{**}, V_{GS} = 0V$ ③
t <sub>rr</sub>	Reverse Recovery Time		26	39	ns	$T_J = 25^{\circ}C$ , $I_F = 75A^{**}$ , $V_{DD} = 20V$
Q <sub>rr</sub>	Reverse Recovery Charge		18	27	nC	di/dt = 100A/µs ③
t <sub>on</sub>	Forward Turn-On Time	Intrinsi	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)			

Note ① through ⑩ ,\* \* are on page 3

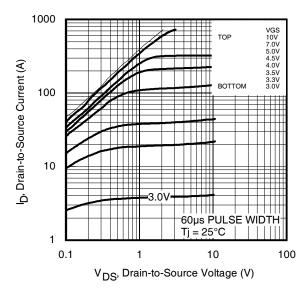
#### Qualification Information<sup>†</sup>

Qualification Level		Automotive (per AEC-Q101) ††		
		Comments: This part number(s) passed Automotive qualification. IR's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.		
Moisture Sensitivity Level		3L-D2 PAK	MSL1	
		3L-TO-262	N/A	
		3L-TO-220	IVA	
	Machine Model	Class M4 (425V)		
	Iviacrime iviodei	(per AEC-Q101-002)		
ECD	Lluna an Dadu Madal	Class H1C (2000V)		
ESD	Human Body Model	(per AEC-Q101-001)		
	01	Class C5 (1125V)		
Charged Device Model		(per AEC-Q101-005)		
RoHS Complia	ant	Yes		

- † Qualification standards can be found at International Rectifier's web site: http://www.irf.com/
- †† Exceptions to AEC-Q101 requirements are noted in the qualification report.

#### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11).
- $\ensuremath{\text{@}}$  Limited by  $T_{Jmax}$ , starting  $T_J = 25^{\circ}C$ , L = 0.066mH,  $R_{G}$  = 25  $\!\Omega,\,I_{AS}$  = 75 A,  $V_{GS}$  =10 V. Part not recommended for use above this value.
- time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$  .
- $\ \, \ \, \ \,$  Limited by  $T_{Jmax}$  , see Fig.12a, 12b, 15, 16 for typical repetitive avalanche performance.
- $\ensuremath{\mathfrak{G}}$  This value determined from sample failure population. 100% tested to this value in production.
- $\ensuremath{\mathfrak{D}}$  This is only applied to TO-220AB package.
- ® When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994.
- $\ \, ^{\mbox{\scriptsize 0}}$  TO-220 device will have an Rth value of 0.65°C/W.
- temperature. Bond wire current limit is 160A. Note that current limitations arising from heating of the device leads may occur with some lead mounting arrangements.
  - \*\* All AC and DC test conditions based on former package limited current of 75A.



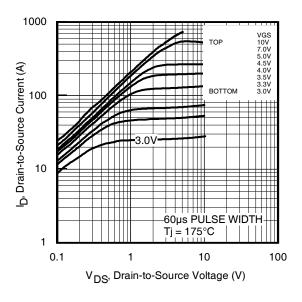
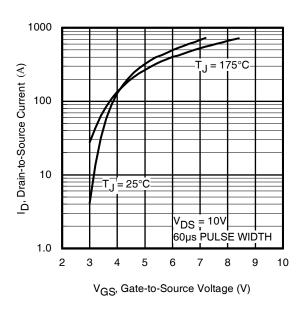


Fig 1. Typical Output Characteristics

Fig 2. Typical Output Characteristics



200

T<sub>J</sub> = 25°C

T<sub>J</sub> = 25°C

T<sub>J</sub> = 175°C

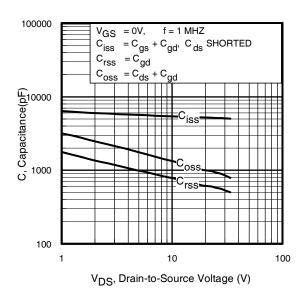
V<sub>DS</sub> = 10V

0

1<sub>D</sub>, Drain-to-Source Current (A)

Fig 3. Typical Transfer Characteristics

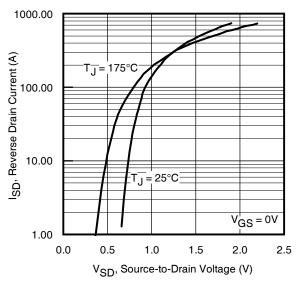
Fig 4. Typical Forward Transconductance vs. Drain Current



6.0 I<sub>D</sub>= 75A  $V_{DS}^{1} = 32V$ 5.0 V<sub>GS</sub>, Gate-to-Source Voltage (V) V<sub>DS</sub>= 20V 4.0 3.0 2.0 1.0 0.0 40 60 0 80 Q<sub>G</sub> Total Gate Charge (nC)

**Fig 5.** Typical Capacitance vs. Drain-to-Source Voltage

**Fig 6.** Typical Gate Charge vs. Gate-to-Source Voltage





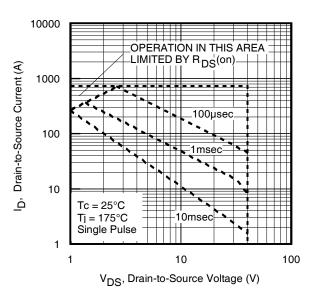
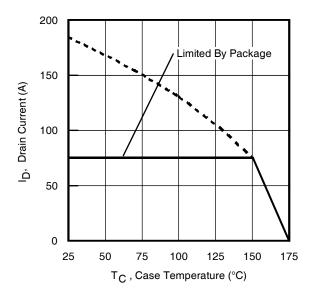
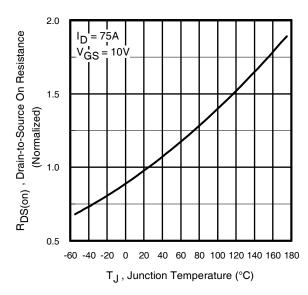


Fig 8. Maximum Safe Operating Area





**Fig 9.** Maximum Drain Current vs. Case Temperature

**Fig 10.** Normalized On-Resistance vs. Temperature

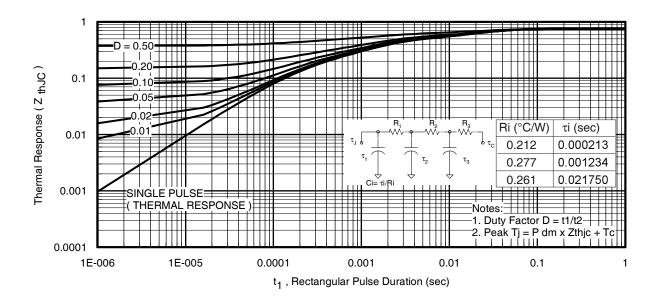


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

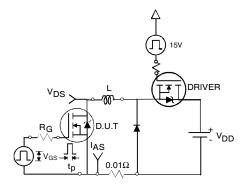


Fig 12a. Unclamped Inductive Test Circuit

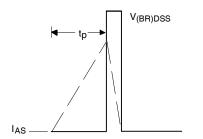


Fig 12b. Unclamped Inductive Waveforms

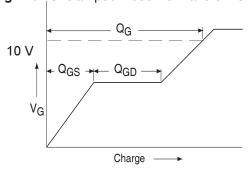
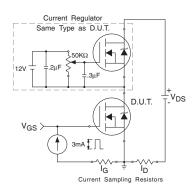
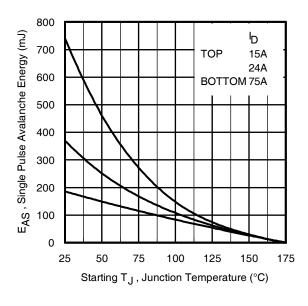


Fig 13a. Basic Gate Charge Waveform



**Fig 13b.** Gate Charge Test Circuit www.irf.com



**Fig 12c.** Maximum Avalanche Energy vs. Drain Current

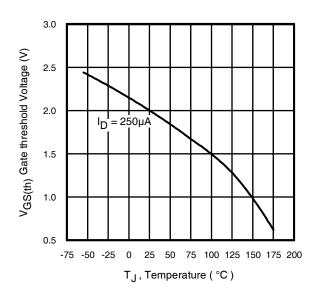


Fig 14. Threshold Voltage vs. Temperature

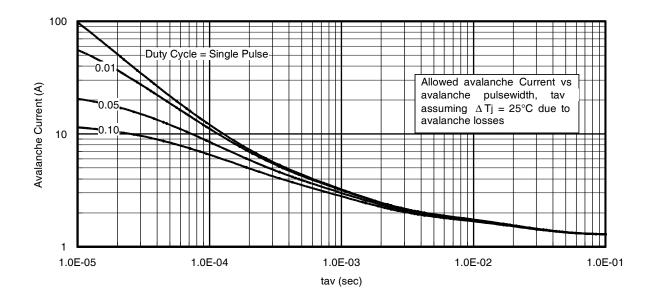
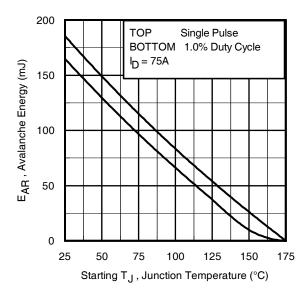


Fig 15. Typical Avalanche Current vs. Pulsewidth



**Fig 16.** Maximum Avalanche Energy vs. Temperature

# Notes on Repetitive Avalanche Curves , Figures 15, 16: (For further info, see AN-1005 at www.irf.com)

- Avalanche failures assumption:
   Purely a thermal phenomenon and failure occurs at a temperature far in excess of T<sub>jmax</sub>. This is validated for every part type.
- Safe operation in Avalanche is allowed as long asT<sub>jmax</sub> is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 12a, 12b.
- P<sub>D</sub> (ave) = Average power dissipation per single avalanche pulse.
- BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. I<sub>av</sub> = Allowable avalanche current.
- 7.  $\Delta T$  = Allowable rise in junction temperature, not to exceed  $T_{jmax}$  (assumed as 25°C in Figure 15, 16).  $t_{av}$  = Average time in avalanche.
  - D = Duty cycle in avalanche =  $t_{av} \cdot f$

 $Z_{th,JC}(D, t_{av})$  = Transient thermal resistance, see figure 11)

$$\begin{split} P_{D\;(ave)} &= 1/2\;(\;1.3 \cdot BV \cdot I_{aV}) = \triangle T/\;Z_{thJC} \\ I_{av} &= 2\triangle T/\;[1.3 \cdot BV \cdot Z_{th}] \\ E_{AS\;(AR)} &= P_{D\;(ave)} \cdot t_{av} \end{split}$$

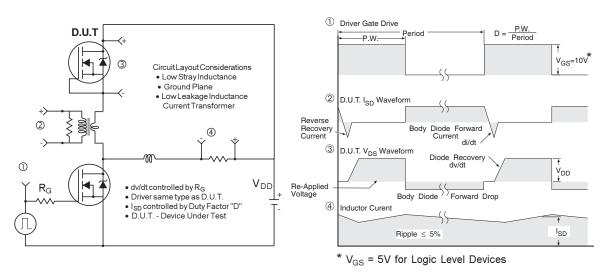


Fig 17. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

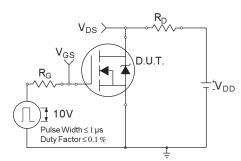


Fig 18a. Switching Time Test Circuit

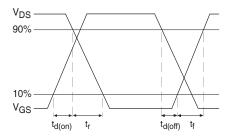
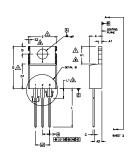


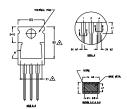
Fig 18b. Switching Time Waveforms

#### International **I⊆R** Rectifier

### TO-220AB Package Outline

Dimensions are shown in millimeters (inches)





SYMBOL

A2 b b1

ь2 ь3

c c1

D D1 D2 E E1

e e1 H1 L L1 øP

0

- DIMENSIONING AND TOLERANCING PER ASME Y14.5 M- 1994,
  DIMENSIONS ARE SHOWN IN INCHES (MILLIMETERS).
  LEAD DIMENSION AND FINSH UNCONTROLLED IN L1.
  DIMENSION D & E DO NOT INCLUDE MOLD FLASH, MOLD FLASH
  SHALL NOT EXCEED JOOS" (0.127) PER SIDE. THESE DIMENSIONS ARE
  MEASURED AT THE OUTERNIST EXTREMES OF THE PLASTIC BODY.
  DIMENSION D & c1 APPLY TO BASE METAL ONLY.
  CONTROLLING DIMENSION : INCHES.
  THERMAL PAD CONTROLE OPTIONAL WITHIN DIMENSIONS EH, 10.2 & E1
  DIMENSION P SY HI D FEIRE A ZYNE WHERE STAMPING.

MILLIMETERS

MIN.

3.56

0.51

2,04

0.38

0.38

1,15

1.15

0.36

14.22

8,38 12,19

9.66 8.38

5.85

12,70

2,54

MAX.

4.82

1,40

2,92

1,01

0.96

1,77

0.56

16.51

9.02 12.88

10.66

8.89

14,73

6.35 4.08

3.42

DIMENSIONS

INCHES

MAX.

190

.055

,115

038

.068

.022

.650

.355 .507

.420

.270 .580

.250

,161

.135

MIN.

.020

.080

,045 .045 .014

.014

.560

.330

.380

.330

.230 .500

.139

.100

NOTES

7,8

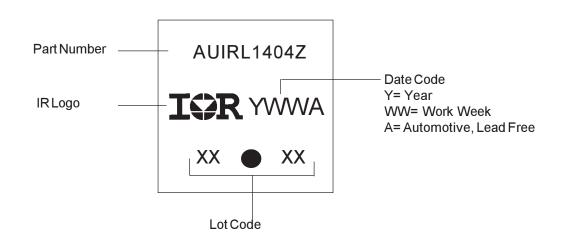
DIMENSION E2 X H1 DEFINE A ZONE WHERE STAMPING AND SINGULATION IRREGULARITIES ARE ALLOWED,

EAD	<b>ASSIGNMENTS</b>

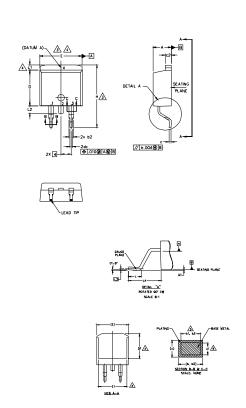
HEXFET

IGBTs, CoPACK

#### TO-220AB Part Marking Information



## $D^2 Pak \ \ Package \ \ Outline \ \ \ (\hbox{\tiny Dimensions are shown in millimeters (inches)})$



- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

3.\DMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.

4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.

5. DIMENSION 61 AND c1 APPLY TO BASE METAL ONLY.

- 6. DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
- 7, CONTROLLING DIMENSION: INCH.
- 8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-263AB.

S Y M		Ŋ				
B O	MILLIM	ETERS	INCHES		O T E S	
L	MIN.	MAX.	MIN.	MAX.	5	
Α	4.06	4.83	.160	.190		
A1	0.00	0.254	.000	.010		
ь	0.51	0,99	.020	.039		
ь1	0.51	0.89	.020	.035	5	
b2	1,14	1.78	.045	.070		
ь3	1.14	1.73	.045	.068	5	
С	0.38	0.74	.015	.029		
c1	0.38	0.58	.015	.023	5	
c2	1,14	1.65	.045	,065		
D	8.38	9.65	.330	.380	3	
D1	6,86	-	.270		4	
Ε	9.65	10.67	.380	.420	3,4	
E1	6.22	-	.245		4	
e	2.54	BSC	.100	BSC		
Н	14,61	15,88	.575	.625		
L	1.78	2.79	.070	.110		
L1	-	1.65	-	.066	4	
L2	1.27	1.78	-	.070		
L3	0.25	BSC	.010	BSC		
L4	4.78	5.28	.188	.208		

#### LEAD ASSIGNMENTS

# **HEXFET**

1.- GATE 2. 4.- DRAIN 3.- SOURCE

#### IGBTs, CoPACK

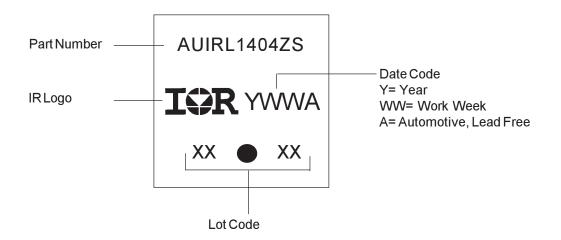
1.- GATE 2, 4.- COLLECTOR 3.- EMITTER

#### DIODES

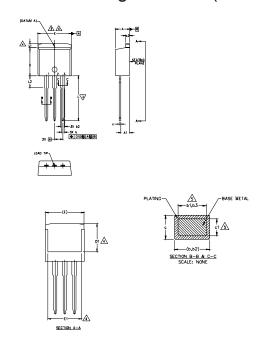
1.- ANODE \*
2. 4.- CATHODE
3.- ANODE

\* PART DEPENDENT

### D<sup>2</sup>Pak Part Marking Information



### TO-262 Package Outline ( Dimensions are shown in millimeters (inches))



- 1, DIMENSIONING AND TOLERANCING PER ASME Y14,5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- 3\DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
- 4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.
- 5. DIMENSION 61 AND C1 APPLY TO BASE METAL ONLY.
- 6. CONTROLLING DIMENSION: INCH.
- 7.- OUTLINE CONFORM TO JEDEC TO-262 EXCEPT A1(max.), b(min.) AND D1(min.) WHERE DIMENSIONS DERIVED THE ACTUAL PACKAGE OUTLINE.

S						
M		DIMEN	SIONS		Ň	
S M B O	MILLIMETERS		INC	HES	N O T E S	
Ĺ	MIN.	MAX.	MIN.	MAX.	S	
Α	4,06	4.83	.160	.190		
A1	2.03	3.02	.080	.119		
b	0.51	0.99	.020	.039		
ь1	0.51	0.89	.020	.035	5	
b2	1,14	1,78	.045	.070		
b3	1,14	1,73	.045	.068	5	
С	0.38	0.74	.015	.029		
c1	0.38	0.58	.015	.023	5	
c2	1,14	1.65	.045	.065		
D	8.38	9.65	.330	.380	3	
D1	6,86	-	.270	-	4	
Ε	9,65	10.67	.380	.420	3,4	
E1	6.22	-	.245		4	
e	2,54	BSC	.100	BSC		
L	13,46	14,10	.530	.555		
L1	-	1.65	-	.065	4	
L2	3,56	3,71	.140	.146		

#### LEAD ASSIGNMENTS

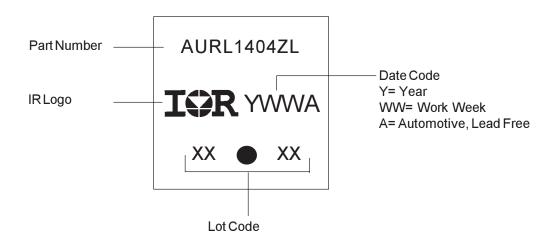
#### **HEXFET**

- 1.- GATE 2.- DRAIN 3.- SOURCE 4.- DRAIN

#### IGBTs, CoPACK

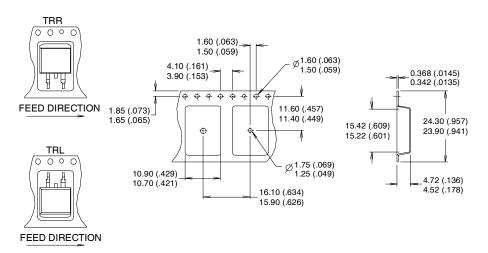
- 1.- GATE
  2.- COLLECTOR
  3.- EMITTER
  4.- COLLECTOR

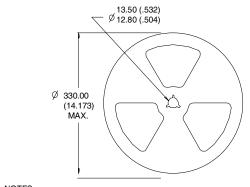
### TO-262 Part Marking Information

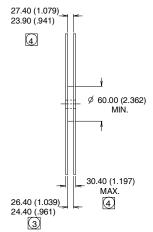


Note: For the most current drawing please refer to IR website at <a href="http://www.irf.com/package/">http://www.irf.com/package/</a>

### D<sup>2</sup>Pak Tape & Reel Infomation







- NOTES:

  1. COMFORMS TO EIA-418.

  2. CONTROLLING DIMENSION: MILLIMETER.

  3. DIMENSION MEASURED @ HUB.

  4. INCLUDES FLANGE DISTORTION @ OUTER EDGE.

### **Ordering Information**

Base part	Package Type	Standard Pack		Complete Part Number
		Form	Quantity	
AUIRL1404Z	TO-220	Tube	50	AUIRL1404Z
AUIRL1404ZL	TO-262	Tube	50	AUIRL1404ZL
AUIRL1404ZS	D2Pak	Tube	50	AUIRL1404ZS
		Tape and Reel Left	800	AUIRL1404ZSTRL
		Tape and Reel Right	800	AUIRL1404ZSTRR

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### AUIRL1404Z/S/L

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